Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10532715	YIP, CHUNG YIN
Examiner	Art Unit
Joseph M Pelham	3742

SEARCHED					
Class	Subclass	Date	Examine		

SEARCH NOTES				
Search Notes	Date	Examiner		
See search history	8/16/08	JP		

INTERFERENCE SEARCH						
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